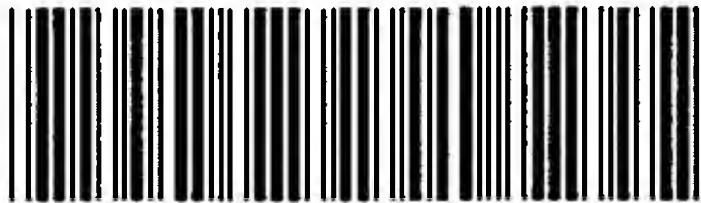


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/711,671	CHIU, YAO-CHENG	
	Examiner	Art Unit	
	Kim T. Huynh	2112	

SEARCHED			
Class	Subclass	Date	Examiner
710	305-306	6/21/2006	KH
710	100	6/21/2006	KH
711	103	6/21/2006	KH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East search uspat; uspgpub; epo; jpo; derwent	6/21/2006	KH